

Description

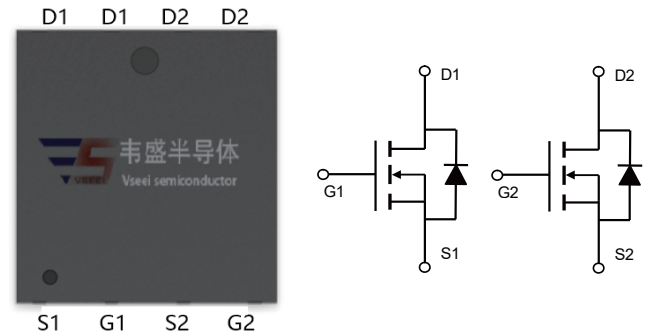
The VSM14DN06 uses advanced trench technology and design to provide excellent $R_{DS(on)}$ with low gate charge. It can be used in a wide variety of applications.

General Features

- $V_{DS} = 60\text{ V}, I_D = 14\text{ A}$
 $R_{DS(on)} < 51\text{ m}\Omega @ V_{GS}=10\text{ V}$
 $R_{DS(on)} < 76\text{ m}\Omega @ V_{GS}=4.5\text{ V}$
ESD Rating: 3000V HBM
- High density cell design for ultra low $R_{DS(on)}$
- Fully characterized avalanche voltage and current
- Good stability and uniformity with high E_{AS}
- Excellent package for good heat dissipation

Application

- Power switching applications
- Hard switched and high frequency circuits
- Uninterruptible power supply



DFN5x6

Schematic

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VSM14DN06	VSM14DN06-D56	DFN5x6	Ø330mm	12mm	5000units

Absolute Maximum Ratings ($T_C=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous	I_D	14	A
Drain Current-Continuous(100°C)	$I_D(100^\circ\text{C})$	10	A
Pulsed Drain Current ($T_C=25^\circ\text{C}$)	I_{DM}	56	A
Maximum Power Dissipation	P_D	23	W
Derating factor		0.189	W/ $^\circ\text{C}$
Single pulse avalanche energy ^(Note 1)	E_{AS}	31	mJ
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 To 150	$^\circ\text{C}$

Thermal Characteristic

Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	5.3	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Ambient ^(Note 2)	$R_{\theta JA}$	50	$^\circ\text{C/W}$

Electrical Characteristics (T_C=25°C unless otherwise noted)

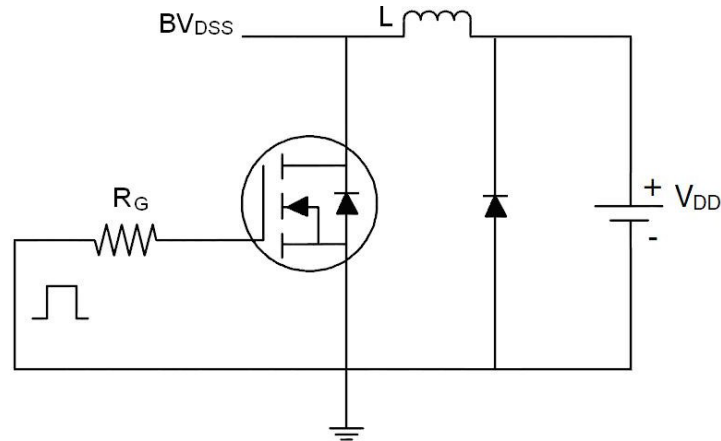
Parameter	Symbol	Condition	Min	Typ	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =250μA	60	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =60V, V _{GS} =0V	-	-	1	uA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V	-	-	±10	uA
On Characteristics						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	1.0	1.6	2.3	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =10A	-	44.5	51	mΩ
		V _{GS} =4.5V, I _D =10A	-	54.4	76	
Forward Transconductance	g _{FS}	V _{DS} =10V, I _D =5A	-	14	-	S
Dynamic Characteristics						
Input Capacitance	C _{iss}	V _{DS} =30V, V _{GS} =0V, F=1.0MHz	-	558.1	-	pF
Output Capacitance	C _{oss}		-	33.4	-	pF
Reverse Transfer Capacitance	C _{rss}		-	37.6	-	pF
Switching Characteristics (Note 3)						
Turn-on Delay Time	t _{d(on)}	V _{DD} =30V, R _L =0.5Ω, V _{GS} =10V, R _{GEN} =3Ω	-	17	-	nS
Turn-on Rise Time	t _r		-	113	-	nS
Turn-off Delay Time	t _{d(off)}		-	26	-	nS
Turn-off Fall Time	t _f		-	35	-	nS
Total Gate Charge	Q _g	V _{DS} =30V, I _D =10A, V _{GS} =10V	-	29.8	-	nC
Gate-Source Charge	Q _{gs}		-	4.5	-	nC
Gate-Drain Charge	Q _{gd}		-	6.7	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _S =14A	-	-	1.2	V
Diode Forward Current	I _S		-	-	14	A
Reverse Recovery Time	t _{rr}	T _J = 25°C, I _F = 10A di/dt = -100A/μs	-	89	-	nS
Reverse Recovery Charge	Q _{rr}		-	153	-	nC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

Notes:

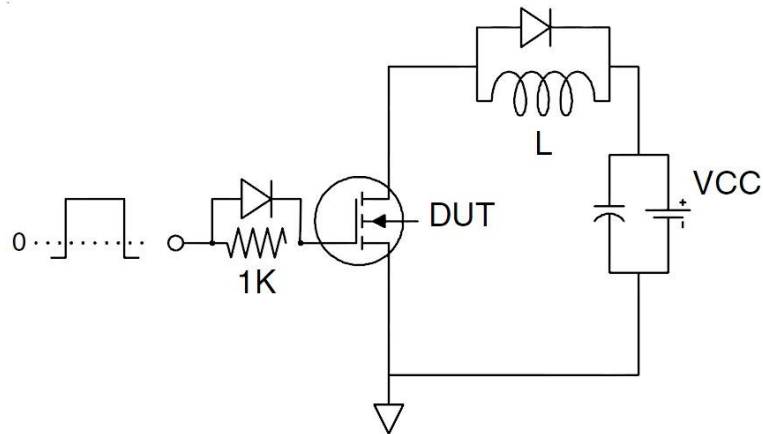
1. EAS condition : T_J=25°C, V_{DD}=30V, V_G=15V, L=0.5mH, R_g=25Ω.
2. The value of R_{θJA} is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C. The maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 150°C may be used if the PCB allows it.
3. Guaranteed by design, not subject to production.
4. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150°C. The SOA curve provides a single pulse rating.

Test Circuit

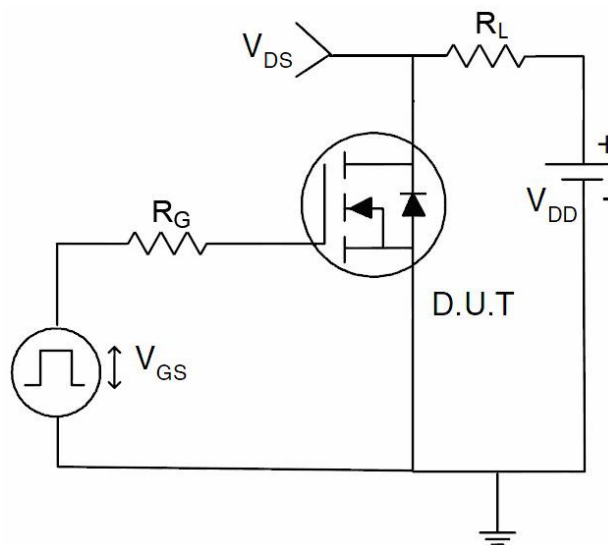
1) E_{AS} Test Circuit



2) Gate Charge Test Circuit



3) Switch Time Test Circuit



Typical Electrical and Thermal Characteristics (Curves)

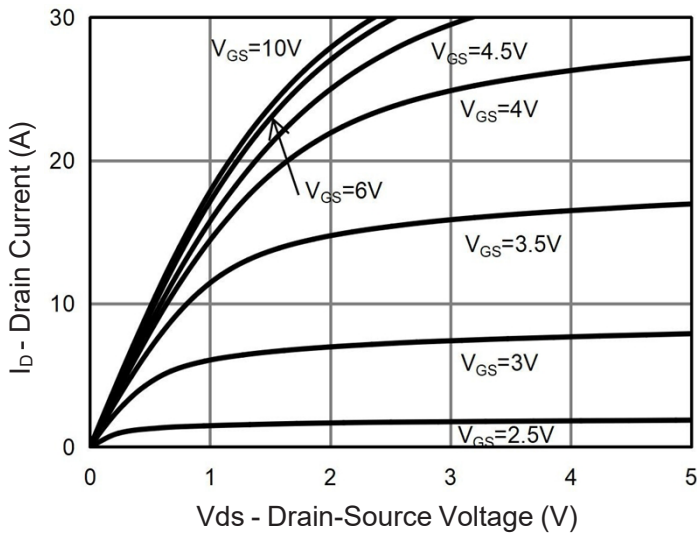


Figure 1 Output Characteristics

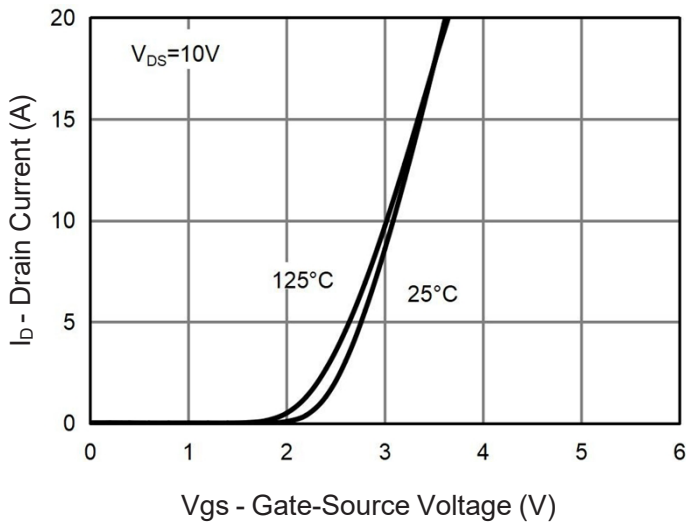


Figure 2 Transfer Characteristics

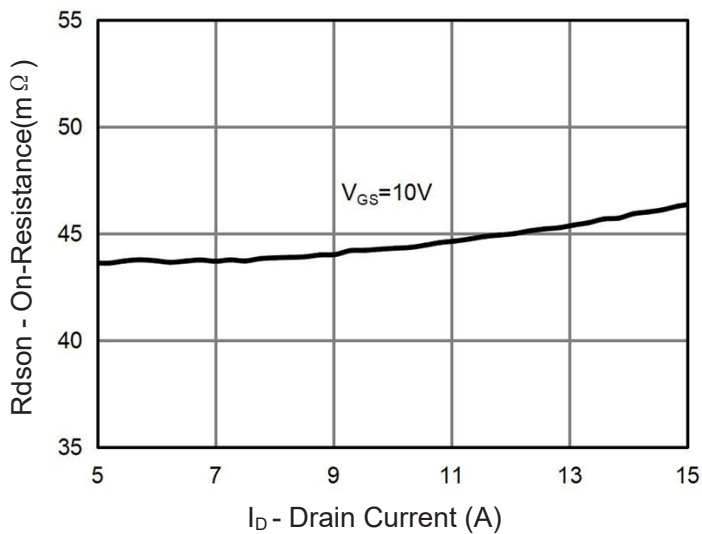


Figure 3 Rdson vs Drain Current

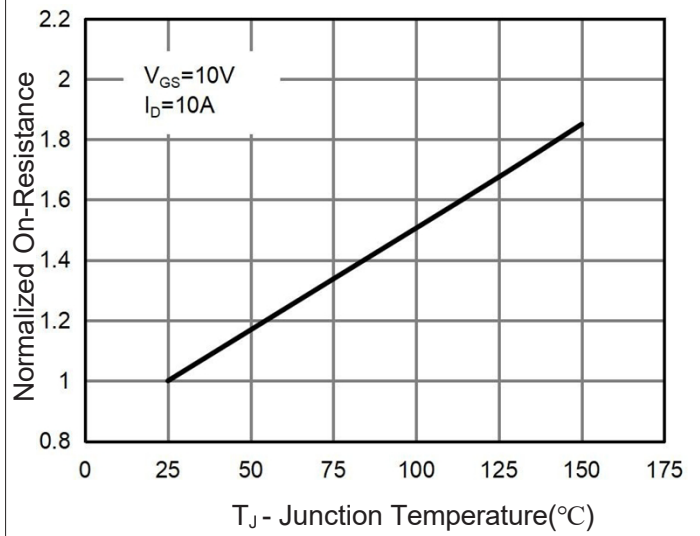


Figure 4 Rdson vs Junction Temperature

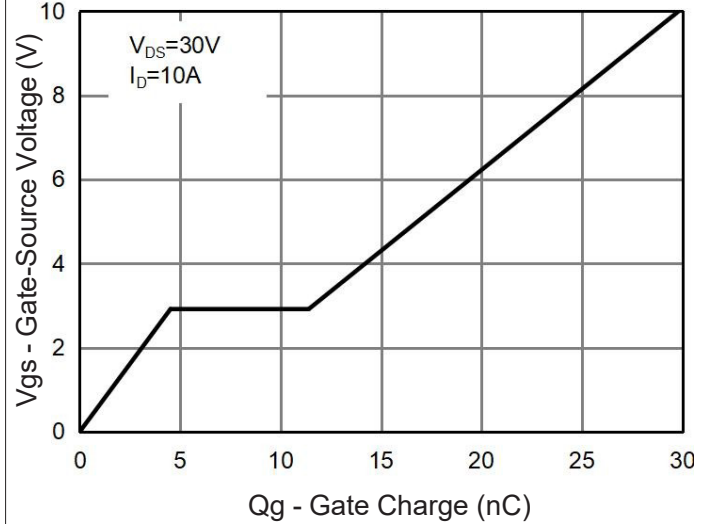


Figure 5 Gate Charge

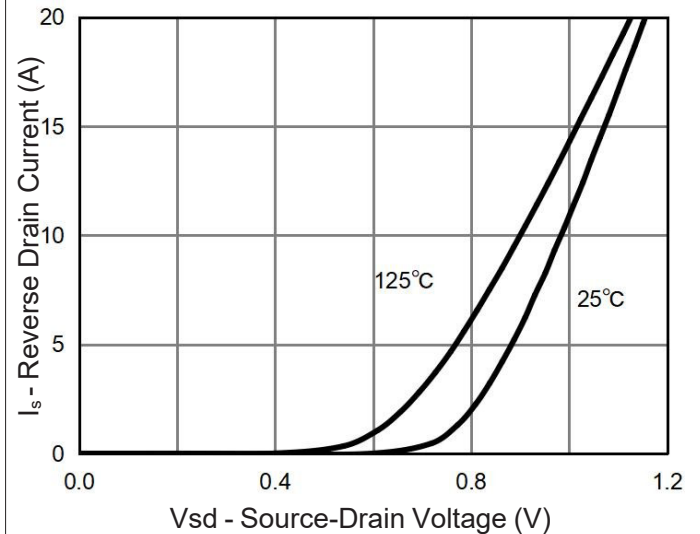
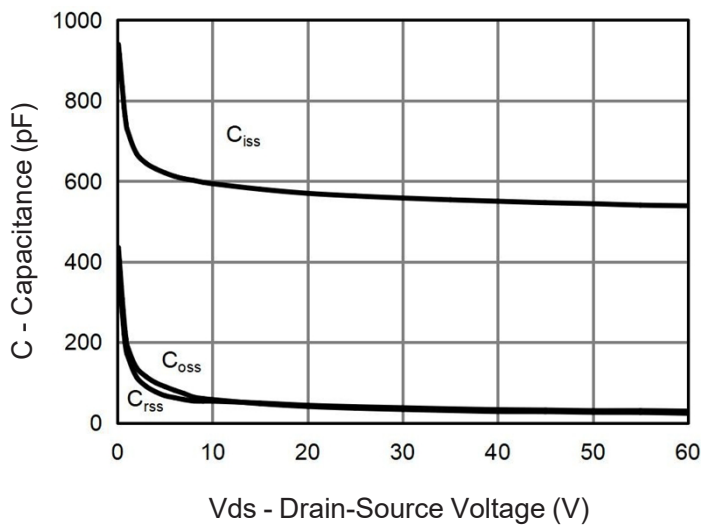
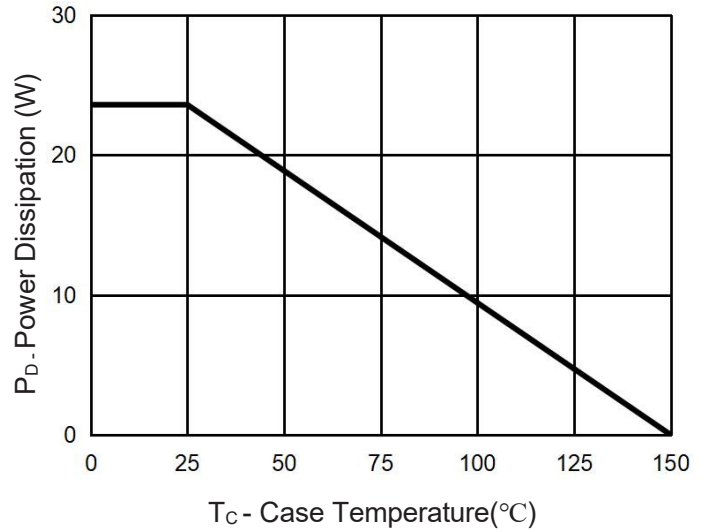
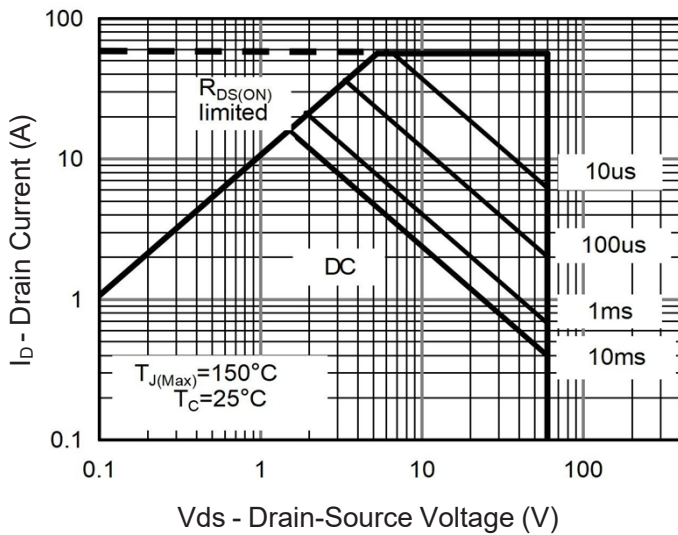
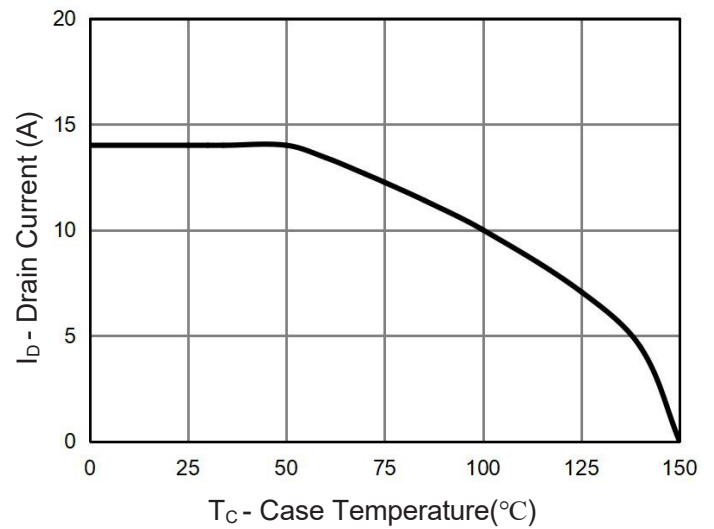
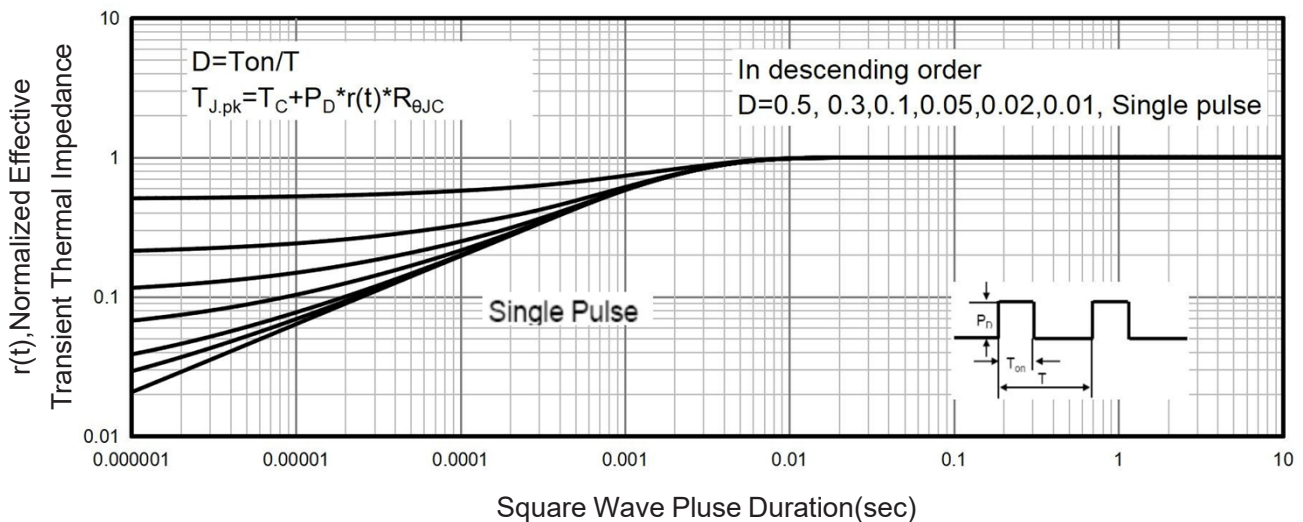


Figure 6 Source- Drain Diode Forward


Figure 7 Capacitance vs Vds

Figure 9 Power De-rating

Figure 8 Safe Operation Area (Note 4)

Figure10 Drain Current De-rating

Figure 11 Normalized Maximum Transient Thermal Impedance